

T-41-83

PC4N35V/PC4N36V PC4N37V

* Lead forming type (I type) is also available. (PC4N35VI/PC4N36VI/PC4N37VI) (Page 482)

■ Features

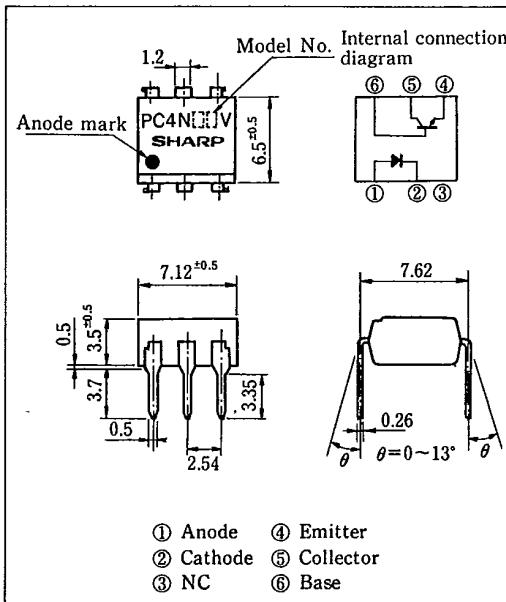
1. High current transfer ratio
(CTR : MIN. 100% at $I_F = 10\text{mA}$, $V_{CE} = 10\text{V}$)
2. Response time
 t_r, t_f : TYP. $3\mu\text{s}$ at $V_{CC} = 10\text{V}$, $I_C = 2\text{mA}$,
 $R_L = 100\Omega$
3. Isolation voltage between Input and Output
PC4N35V (V_{ISO} : 3,550Vrms), PC4N36V (V_{ISO} : 2,500Vrms), PC4N37V (V_{ISO} : 1,500Vrms)
4. UL recognized, file No. 64380
TÜV approved, PC4N35V/36V:
No. R40182, PC4N37V: No. R40183

■ Applications

1. I/O interfaces for computers
2. System appliances, measuring instruments
3. Signal transmission between circuits of different potentials and impedances

General Purpose Type Photocoupler

■ Outline Dimensions (Unit : mm)



■ Absolute Maximum Ratings

(Ta=25°C)

Parameter	Symbol	Rating	Unit
Input	Forward current	I_F	mA
	*1 Peak forward current	I_{FM}	A
	Reverse voltage	V_R	V
	Power dissipation	P	mW
Output	Collector-emitter voltage	V_{CEO}	V
	Emitter-collector voltage	V_{ECO}	V
	Collector-base voltage	V_{CBO}	V
	Collector current	I_C	mA
	Collector power dissipation	P_C	mW
Total power dissipation		P_{tot}	mW
*2 Isolation voltage	PC4N35V	3,550	Vrms
	PC4N36V	2,500	
	PC4N37V	1,500	
Operating temperature	T_{opr}	-55 ~ +100	°C
Storage temperature	T_{stg}	-55 ~ +150	°C
*3 Soldering temperature	T_{sol}	260	°C

*1 Pulse width $\leq 1\mu\text{s}$, Duty ratio = 0.001

*2 RH = 40 ~ 60%, AC for 1 minute

*3 For 10 seconds

SHARP

■ Electro-optical Characteristics

T-41-83

(Ta=25°C)

	Parameter	Symbol	Conditions	MIN.	TYP.	MAX.	Unit
Input	Forward voltage	V _F	I _F =10mA	—	1.2	1.5	V
	Reverse current	I _R	V _R =4V	—	—	10	μA
	Terminal capacitance	C _t	V=0, f=1MHz	—	50	—	pF
Output	Collector darkcurrent	I _{CEO}	V _{CE} =10V	—	—	5×10 ⁻⁸	A
			Ta=100°C, V _{CE} =30V	—	—	5×10 ⁻⁴	A
	Collector-emitter breakdown voltage	BV _{CEO}	I _c =0.1mA, I _F =0	30	—	—	V
Transfer characteristics	Emitter-collector breakdown voltage	BV _{ECO}	I _E =10μA, I _F =0	7	—	—	V
	Collector-base breakdown voltage	BV _{CBO}	I _c =0.1mA, I _F =0	70	—	—	V
	**Current transfer ratio	CTR	I _F =10mA, V _{CE} =10V	100	—	—	%
			Ta=-55°C, I _F =10mA, V _{CE} =10V	40	—	—	%
			Ta=100°C, I _F =10mA, V _{CE} =10V	40	—	—	%
	Collector-emitter saturation voltage	V _{CE(sat)}	I _F =50mA, I _c =2mA	—	—	0.3	V
	Isolation resistance	R _{ISO}	DC500V, HR=40~60%	5×10 ¹⁰	10 ¹¹	—	Ω
	Floating capacitance	C _f	V=0, f=1MHz	—	1.0	2.5	pF
	Response time (Rise)	t _r	V _{cc} =10V, I _c =2mA	—	3	10	μs
	Response time (Fall)	t _f	R _L =100Ω, R _{BE} =∞	—	3	10	μs

*4 Pulse test : input pulse width=300μs, duty ratio≤0.02

6

Fig. 1 Forward Current vs. Ambient Temperature

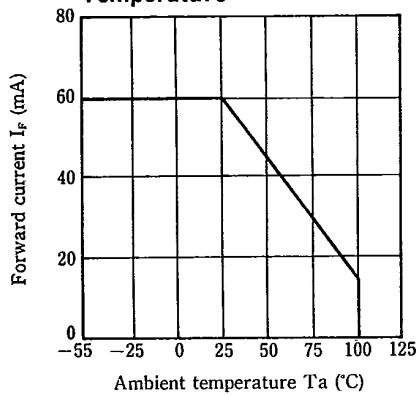


Fig. 2 Collector Power Dissipation vs. Ambient Temperature

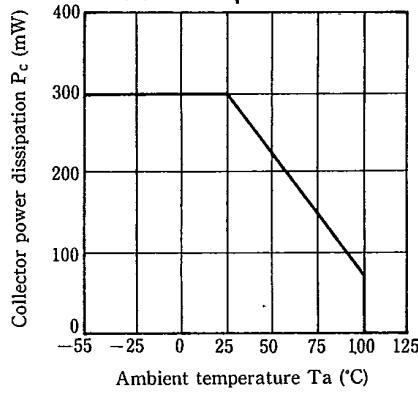


Fig. 3 Forward Current vs. Forward Voltage

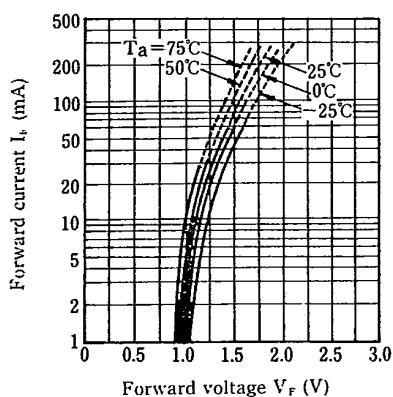


Fig. 4 Current Transfer Ratio vs. Forward Current

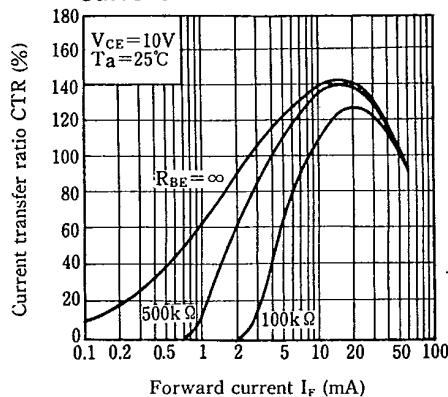
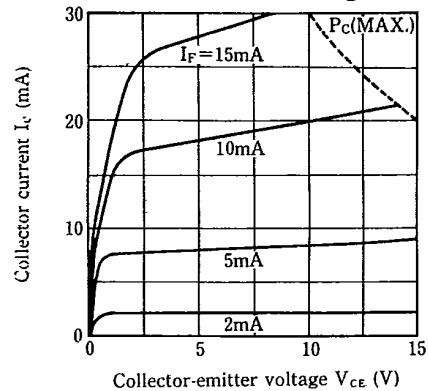
Fig. 5 Collector Current vs. Collector-emitter Voltage ($T_a = 25^\circ\text{C}$)

Fig. 6 Relative Current Transfer Ratio vs. Ambient Temperature

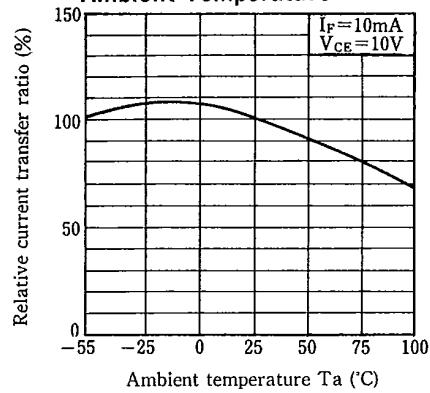


Fig. 7 Collector-emitter Saturation Voltage vs. Ambient Temperature

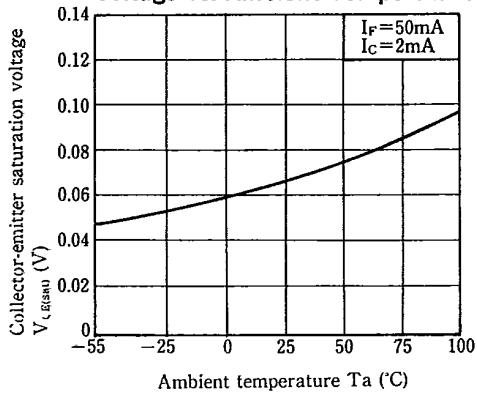


Fig. 8 Collector Dark Current vs. Ambient Temperature

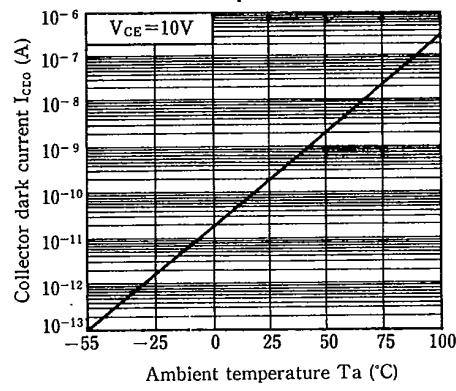


Fig. 9 Response Time vs. Load Resistance

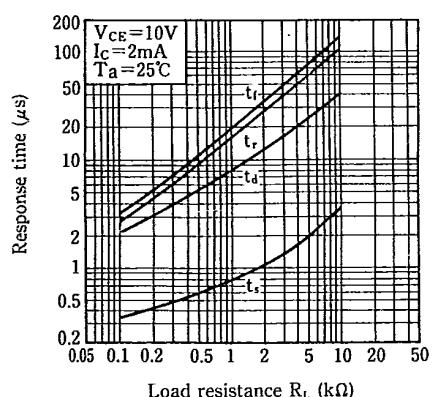


Fig. 10 Frequency Response

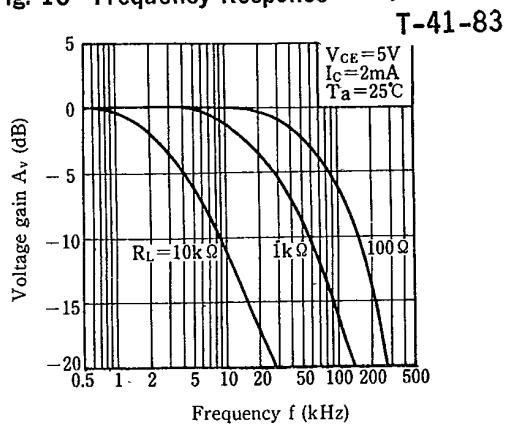
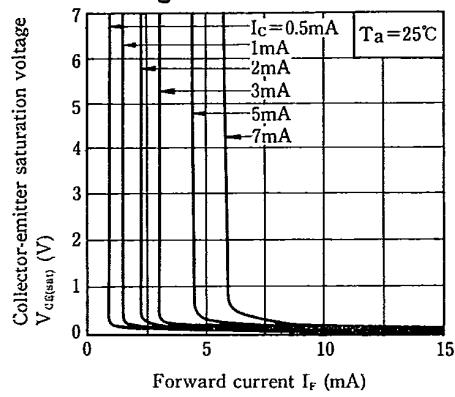
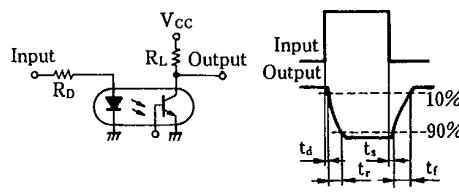


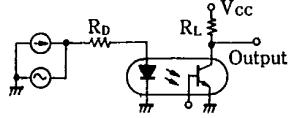
Fig. 11 Collector-emitter Saturation Voltage vs. Forward Current



Test Circuit for Response Time



Test Circuit for Frequency Response



6